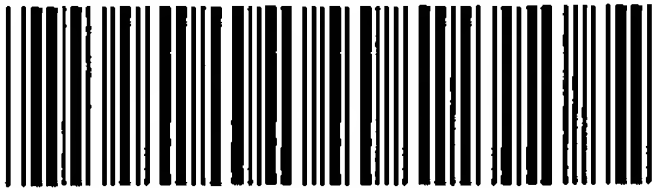


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/635,083	ADKISSON ET AL.	
	Examiner	Art Unit	
	Toan M. Le	2863	

SEARCHED			
Class	Subclass	Date	Examiner
702	186	6/20/2007	TL
714	47-49	6/20/2007	TL
714	1-3,25	6/20/2007	TL
714	699,704	6/20/2007	TL
714	706,709	6/20/2007	TL
714	735-736	6/2/2007	TL
712	224	6/20/2007	TL
716	4	6/20/2007	TL
Above	Updated	12/19/2007	TL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
702/186; 714/1-3,25,47-49,699,704,706,709,735-736; 712/224; 716/4 (Counter Debug Match Threshold Event)	6/20/2007	TL
East- See Search History Printout	6/20/2007	TL
702/186; 714/1-3,25,47-49,699,704,706,709,735-736; 712/224; 716/4 (Counter Debug Match Threshold Event Increment)	12/19/2007	TL
Counter Debug Match Threshold Compare Activate Event Signal Bits Bus Circuit Increment	12/19/2007	TL
East- See Search History Printout	12/19/2007	TL